

NIM-S26B

Supplier: POKI / Gift box size: 224(L)*140(W)*69(H) mm

Package Drop Test Report

Report NO: 17I030003



Summary	<p><input checked="" type="checkbox"/> Pass</p> <p><input type="checkbox"/> Fail Note : There is/are ____ defect(s) not list in the report, please check it in the DTS Website.</p> <p><input type="checkbox"/> Pass with Deviation</p> <p>Comment: _____</p>
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Issue date

2017-01-12

QE Manager

KJ Wang

Test Engineer

Rex Chang

Test item list

1. *Test item list* ----- 2
2. *Configuration of EUT* ----- 3
3. *Package drop test* ----- 4

Testing Result

Num	Test item list	Result	Remark
1	Package drop test	Pass	



Package Drop Test

Test Date: 01-12-2017

Test Product: NIM-S26B A1.0

Test Site: AAEON QE Dept.

Test Standard:

Reference ISTA PROJECT 2A

Test Equipment:

Drop Tester

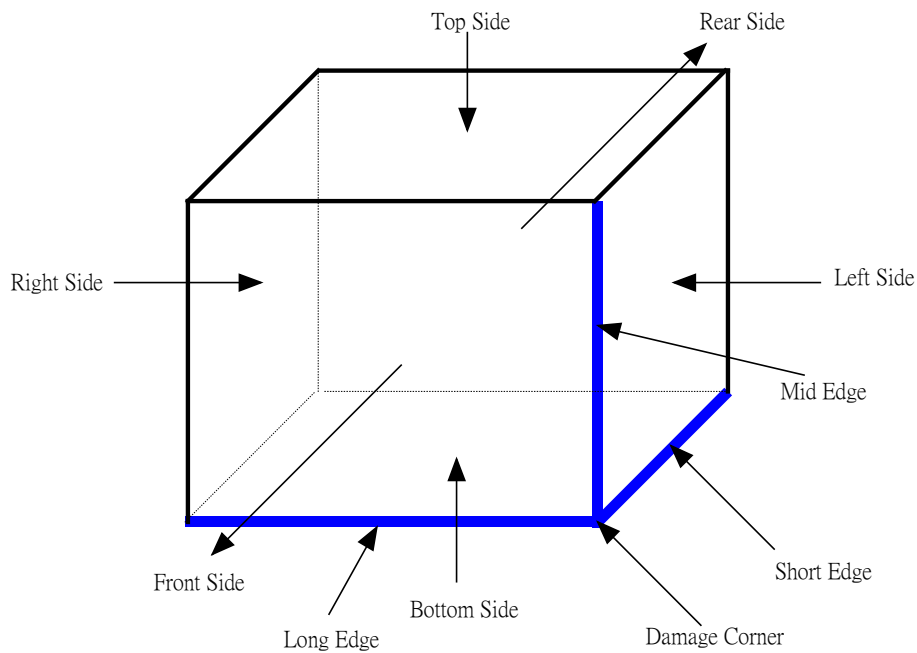
KING DESIGN Co. LTD.

Model: KD-128A

Serial Number: UU110099190

Test Condition:

1. Test Phase: One corner. Three edges. Six face
2. Test Cycle: 1 Cycle
3. Test Height: 97cm
4. Test Weight: 0.40Kg
5. Sample Package: 1unit in single-package.
6. Test Drawing:



Test Result:

Packaging is not broken, main board no structure deformation and function was working normally after drop test.